

### **General Description**

The SJZ016N10 uses SGT technology to provide excellent Rds(on), low gate charge and fast switching characteristics. This device is suitable for use as a wide variety of applications.

#### Features

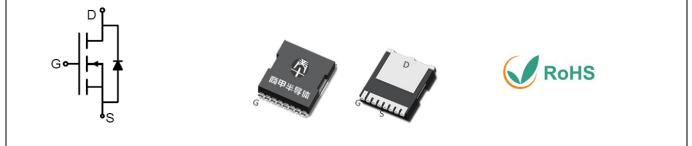
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

### Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

## Key Performance Parametes

Parameter	Value	Unit
V <sub>DS</sub>	100	V
R <sub>DS(ON)_TYP</sub>	1.25	mΩ
ID	359	А
Q <sub>G</sub>	150	nC



Schematic Diagram

TOLL top&bottom view

#### Package Marking and Ordering Information

Device/Ordering Code	Marking	Package	Reel Size	Tape width	Quantity
SJZ016N10	SJZ016N10	TOLL	١	\	١

## Table 1. Absolute Maximum Ratings ( $T_c=25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	100	V
V <sub>GS</sub>	Gate-Source Voltage (V <sub>DS</sub> =0V)	±20	V
Drain Current-Continuous(Tc=25°C)		359	А
lD	Drain Current-Continuous(Tc=100℃)	227	А
DM (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	1436	А
Maximum Power Dissipation(T <sub>c</sub> =25°C)		313	W
Po	Maximum Power Dissipation(Tc=100°C)	125	W
E <sub>AS</sub>	Avalanche energy (Note 2)	2500	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	Ĉ

## Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
Rejc	Thermal Resistance, Junction-to-Case		0.4	°C/W



## Table 3. Electrical Characteristics (T<sub>J</sub>= $25^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
On/Off States	-					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	100			V
	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V TJ=25℃			1	μA
IDSS		V <sub>DS</sub> =100V, V <sub>GS</sub> =0V T <sub>J</sub> =125℃			100	μA
Igss	Gate-Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	2		4	V
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =15A		36		S
RDS(ON)	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A T <sub>J</sub> =25℃		1.25	1.5	mΩ
Dynamic Chara	acteristics					
Ciss	Input Capacitance			10500		pF
Coss	Output Capacitance	V <sub>DS</sub> =50V,V <sub>GS</sub> =0V, f=1.0MHz		3740		pF
Crss	Reverse Transfer Capacitance			60		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		1.1		Ω
Switching Para	meters			•		
t <sub>d(on)</sub>	Turn-on Delay Time			36		nS
tr	Turn-on Rise Time	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V,		25		nS
$t_{d(off)}$	Turn-Off Delay Time	R∟=2.5Ω, R <sub>GEN</sub> =6Ω		90		nS
tr	Turn-Off Fall Time			40		nS
Qg	Total Gate Charge			150		nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =20A		48		nC
$Q_{gd}$	Gate-Drain Charge			30		nC
Source-Drain D	Diode Characteristics					
I <sub>SD</sub>	Source-Drain Current (Body Diode)				359	А
V <sub>SD</sub>	Forward on Voltage (Note 3)	V <sub>GS</sub> =0V, I <sub>S</sub> =20A			1.2	V
trr	Reverse Recovery Time	l⊧=20A, dl/dt=500A/μs		55		ns
Q <sub>rr</sub>	Reverse Recovery Charge	l⊧=20A, dI/dt=500A/μs		333		nC

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

Notes 2.E<sub>AS</sub> condition:  $T_J=25^{\circ}C$ ,  $V_{DD}=50V$ ,  $V_G=10V$ ,  $Rg=25\Omega$ , L=0.5mH.

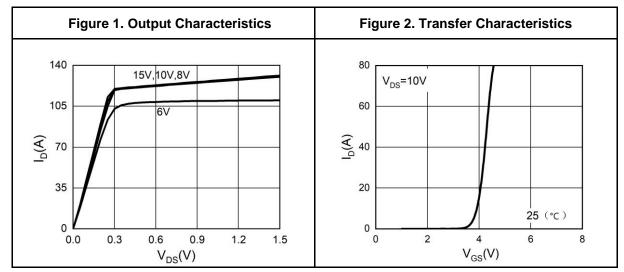
Notes 3. Repetitive Rating: Pulse width limited by maximum junction temperature.

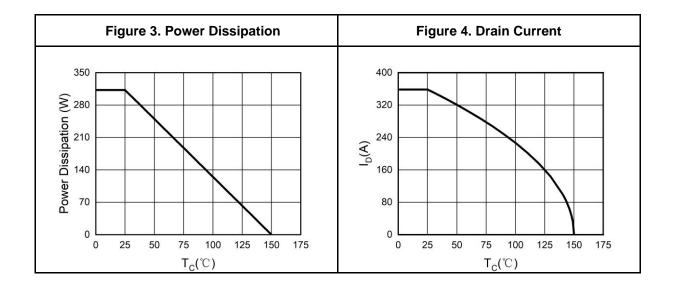


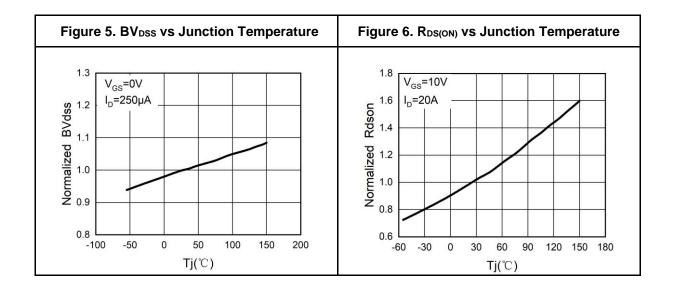
# SJZ016N10

## **100V N-Channel Trench Power MOSFET**

# **Typical Electrical And Thermal Characteristics (Curves)**



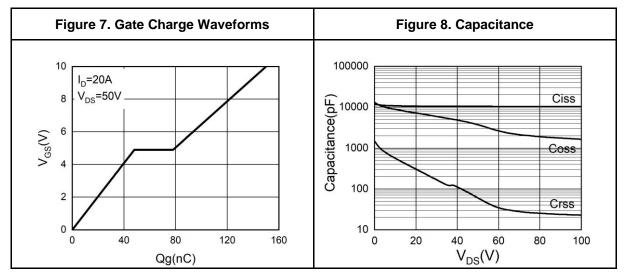


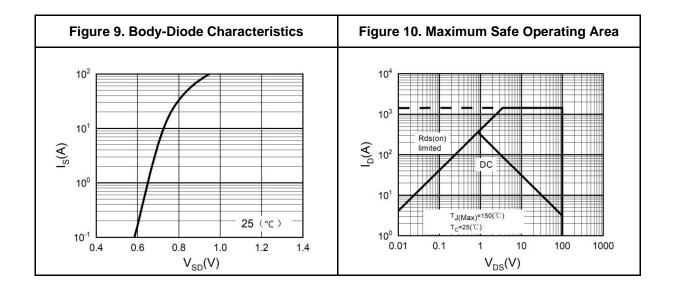




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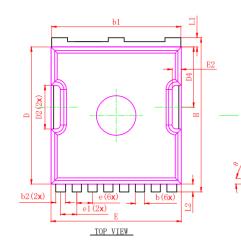
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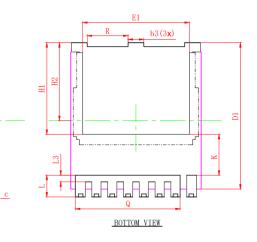


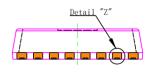




# **TOLL Package Information**









SYMBOL	l	MILLIMETER		
SIMBOL	MIN.	NOM.	MAX.	
A	2.200	2.300	2.400	
A1	1.700	1.800	1.900	
b	0.600	0.700	0.800	
b1	9.700	9.800	9.900	
b2	0.650	0.750	0.850	
b3	1.100	1.200	1.300	
С	0.400	0.500	0.600	
D	10.300	10.400	10.500	
D1	11.000	11.100	11.200	
D2	3.200	3.300	3.400	
D4	4.470	4.570	4.670	
E	9.800	9.900	10.000	
E1	8.000	8.100	8.200	
E2	0.500	0.600	0.700	
е	1.200 BSC			
e1	1.225 BSC			
H	11.600	11.700	11.800	
H1	6.950 BSC			
H2		5.900 BSC		
i		0.100 REF.		
j		0.350 REF.		
K	3.100 REF.			
L	1.550	1.650	1.750	
L1	0.600	0.700	0.800	
L2	0.500	0.600	0.700	
L3	0.400	0.500	0.600	
Q	7.950 REF.			
R	3.000	3.100	3.200	
θ	10° REF.			



## Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor.

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